

NTHD4502N

Power MOSFET

30 V, 3.9 A, Dual N-Channel ChipFET™

Features

- Planar Technology Device Offers Low $R_{DS(on)}$ and Fast Switching Speed
- Leadless ChipFET Package has 40% Smaller Footprint than TSOP-6. Ideal Device for Applications Where Board Space is at a Premium.
- ChipFET Package Exhibits Excellent Thermal Capabilities. Ideal for Applications Where Heat Transfer is Required.
- Pb-Free Package is Available

Applications

- DC-DC Buck or Boost Converters
- Low Side Switching
- Optimized for Battery and Low Side Switching Applications in Computing and Portable Equipment

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage	V_{DSS}	30	V	
Gate-to-Source Voltage	V_{GS}	± 20	V	
Continuous Drain Current (Note 1)	Steady State	$T_A = 25^\circ\text{C}$	2.9	A
		$T_A = 85^\circ\text{C}$		
	$t \leq 5 \text{ s}$	$T_A = 25^\circ\text{C}$	3.9	
Power Dissipation (Note 1)	Steady State	$T_A = 25^\circ\text{C}$	1.13	W
		$t \leq 5 \text{ s}$	2.1	
Continuous Drain Current (Note 2)	Steady State	$T_A = 25^\circ\text{C}$	2.2	A
		$T_A = 85^\circ\text{C}$	1.6	
Power Dissipation (Note 2)	Steady State	$T_A = 25^\circ\text{C}$	0.64	W
Pulsed Drain Current	$t_p = 10 \mu\text{s}$	I_{DM}	12	A
ESD Capability (Note 3)	$C = 100 \text{ pF}$, $R_S = 1500 \Omega$	ESD-HBM	125	V
Operating Junction and Storage Temperature	T_J , T_{STG}	-55 to 150		$^\circ\text{C}$
Source Current (Body Diode)	I_S	2.5	A	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	T_L	260	$^\circ\text{C}$	

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

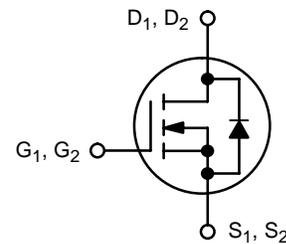
1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
2. Surface Mounted on FR4 Board using the minimum recommended pad size (Cu area = 0.214 in sq).
3. ESD Rating Information: HBM Class 0.



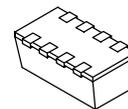
ON Semiconductor®

<http://onsemi.com>

$V_{(BR)DSS}$	$R_{DS(on)}$ TYP	I_D MAX
30 V	80 m Ω @ 10 V	3.9 A
	110 m Ω @ 4.5 V	

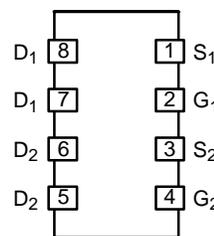


N-Channel MOSFET

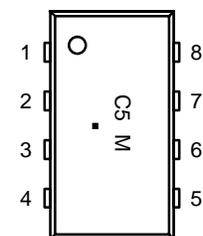


ChipFET
CASE 1206A
STYLE 2

PIN CONNECTIONS



MARKING DIAGRAM



- C5 = Specific Device Code
- M = Month Code
- = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping†
NTHD4502NT1	ChipFET	3000/Tape & Reel
NTHD4502NT1G	ChipFET (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient – Steady State (Note 4)	$R_{\theta JA}$	110	°C/W
Junction-to-Ambient – $t \leq 5$ s (Note 4)	$R_{\theta JA}$	60	
Junction-to-Ambient – Steady State (Note 5)	$R_{\theta JA}$	195	

4. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
 5. Surface Mounted on FR4 Board using the minimum recommended pad size (Cu area = 0.214 in sq).

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0$ V, $I_D = 250$ μ A	30	36		V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS} = 0$ V, $V_{DS} = 24$ V			1.0	μ A
		$V_{GS} = 0$ V, $V_{DS} = 24$ V, $T_J = 125^\circ\text{C}$			10	
Gate-to-Source Leakage Current	I_{GSS}	$V_{DS} = 0$ V, $V_{GS} = \pm 20$ V			± 100	nA

ON CHARACTERISTICS (Note 6)

Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}$, $I_D = 250$ μ A	1.0	1.65	3.0	V
Drain-to-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10$ V, $I_D = 2.9$ A		78	85	m Ω
		$V_{GS} = 4.5$ V, $I_D = 2.2$ A		105	140	
Forward Transconductance	g_{FS}	$V_{DS} = 15$ V, $I_D = 2.9$ A		3.8		S

CHARGES AND CAPACITANCES

Input Capacitance	C_{ISS}	$V_{GS} = 0$ V, $f = 1.0$ MHz, $V_{DS} = 15$ V		140		pF
Output Capacitance	C_{OSS}			53		
Reverse Transfer Capacitance	C_{RSS}			16		
Input Capacitance	C_{ISS}	$V_{GS} = 0$ V, $f = 1.0$ MHz, $V_{DS} = 24$ V		135	250	pF
Output Capacitance	C_{OSS}			42	75	
Reverse Transfer Capacitance	C_{RSS}			13	25	
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 10$ V, $V_{DS} = 15$ V, $I_D = 2.9$ A		3.6	7.0	nC
Threshold Gate Charge	$Q_{G(TH)}$			0.3		
Gate-to-Source Charge	Q_{GS}			0.6		
Gate-to-Drain Charge	Q_{GD}			0.7		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 4.5$ V, $V_{DS} = 24$ V, $I_D = 2.9$ A		1.9		nC
Threshold Gate Charge	$Q_{G(TH)}$			0.3		
Gate-to-Source Charge	Q_{GS}			0.6		
Gate-to-Drain Charge	Q_{GD}			0.9		

6. Pulse Test: Pulse Width ≤ 300 μ s, Duty Cycle $\leq 2\%$.

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ELECTRICAL CHARACTERISTICS (continued) ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
DRAIN-SOURCE DIODE CHARACTERISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0\text{ V}, I_S = 2.5\text{ A}$		0.85	1.2	V
Reverse Recovery Time	t_{RR}	$V_{GS} = 0\text{ V}, I_S = 2.9\text{ A},$ $di_S/dt = 100\text{ A}/\mu\text{s}$		8.6		ns
Reverse Recovery Charge	Q_{RR}			4.0		nC
Reverse Recovery Time	t_{RR}	$V_{GS} = 0\text{ V}, I_S = 1.0\text{ A},$ $di_S/dt = 100\text{ A}/\mu\text{s}$		8.4		ns
Reverse Recovery Charge	Q_{RR}			4.0		nC

SWITCHING CHARACTERISTICS (Note 7)

Turn-On Delay Time	$t_{d(ON)}$	$V_{GS} = 10\text{ V}, V_{DD} = 24\text{ V},$ $I_D = 1\text{ A}, R_G = 6\ \Omega$		6.5	12	ns
Rise Time	t_r			5.4	10	
Turn-Off Delay Time	$t_{d(OFF)}$			14.9	25	
Fall Time	t_f			1.8	5.0	
Turn-On Delay Time	$t_{d(ON)}$	$V_{GS} = 4.5\text{ V}, V_{DD} = 24\text{ V},$ $I_D = 2.9\text{ A}, R_G = 2.5\ \Omega$		7.8		ns
Rise Time	t_r			12.6		
Turn-Off Delay Time	$t_{d(OFF)}$			9.6		
Fall Time	t_f			2.8		

7. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

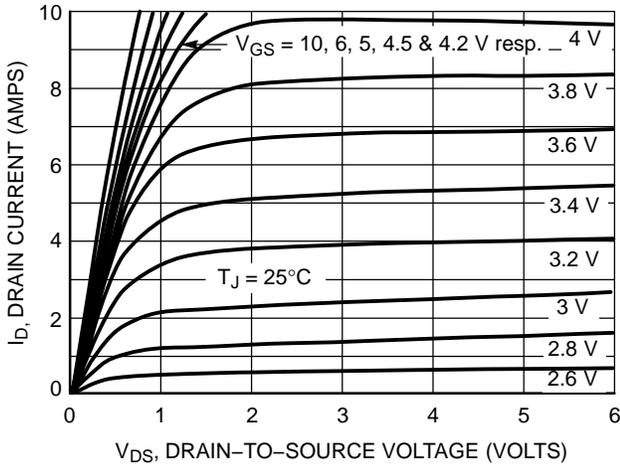


Figure 1. On-Region Characteristics

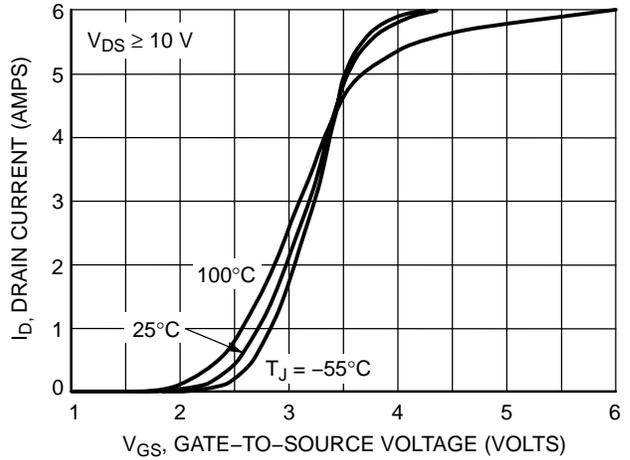


Figure 2. Transfer Characteristics

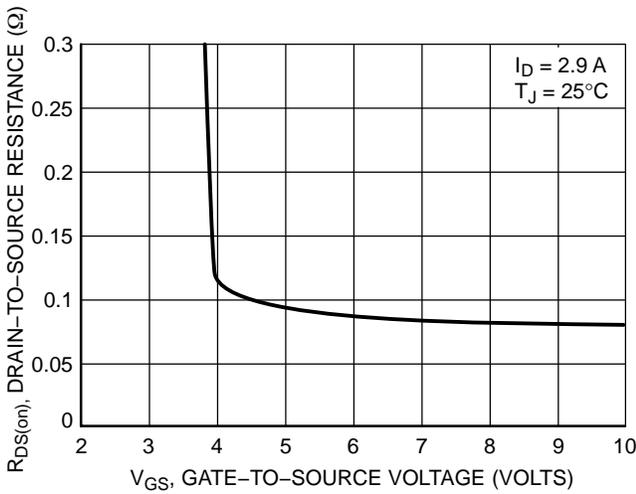


Figure 3. On-Resistance vs. Gate-to-Source Voltage

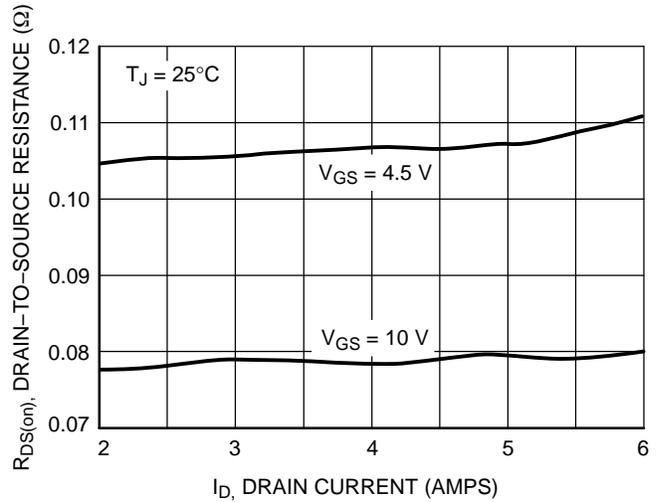


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

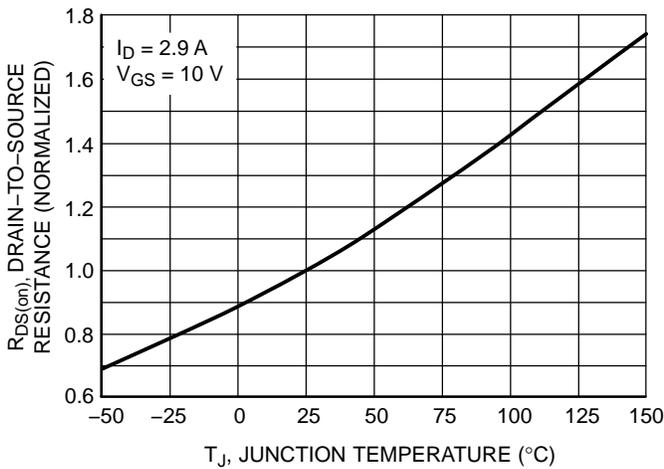


Figure 5. On-Resistance Variation with Temperature

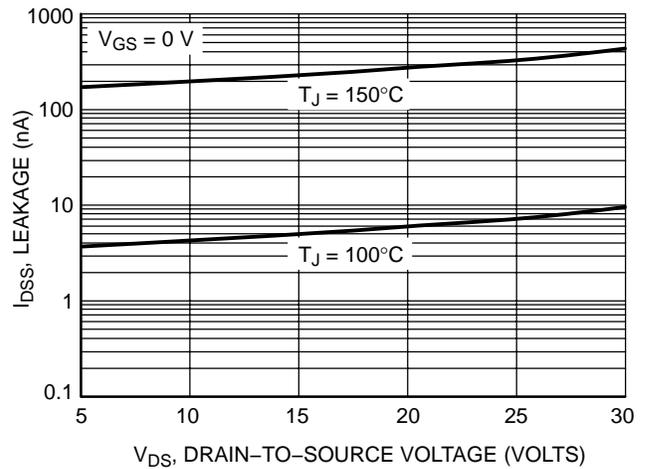


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES

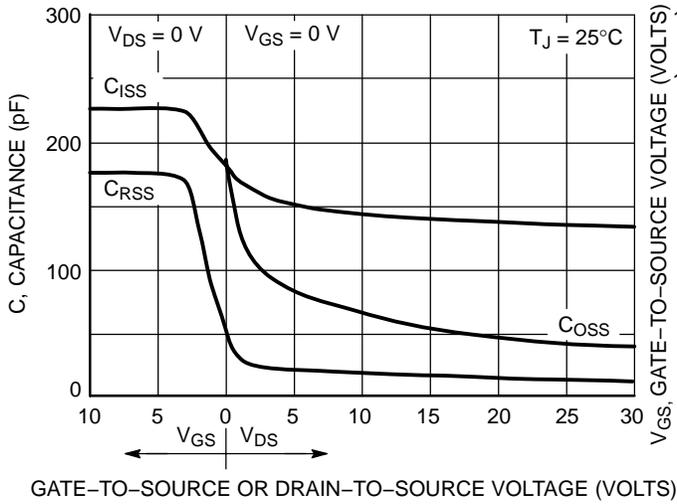


Figure 7. Capacitance Variation

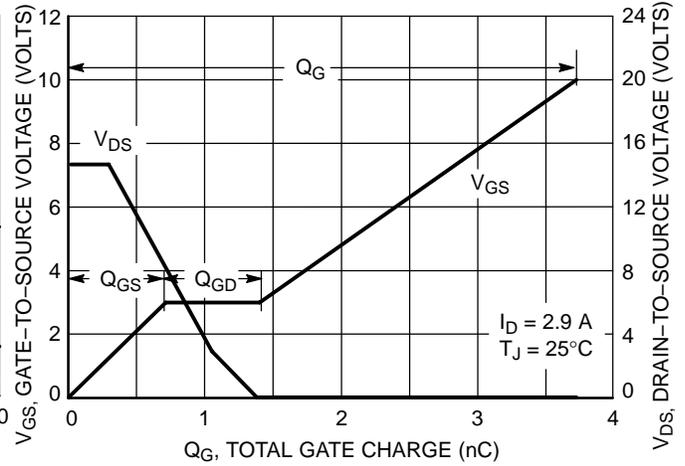


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

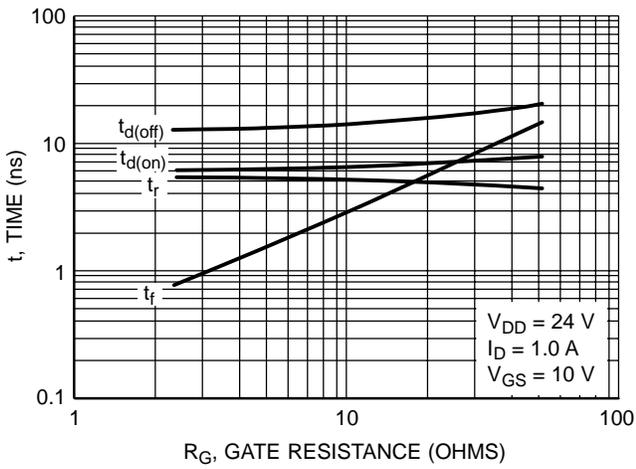


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

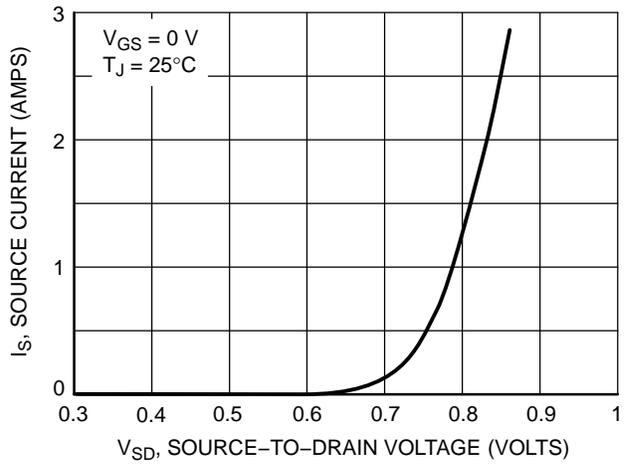
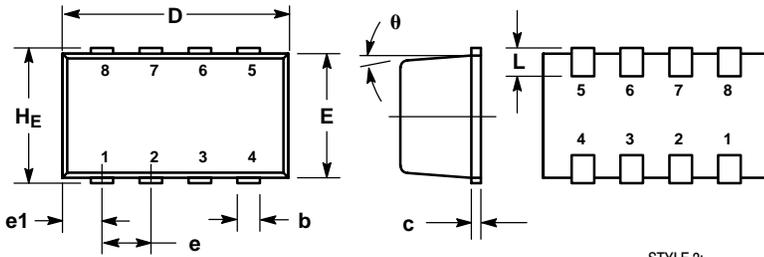


Figure 10. Diode Forward Voltage vs. Current

NTHD4502N

PACKAGE DIMENSIONS

ChipFET™
CASE 1206A-03
ISSUE G

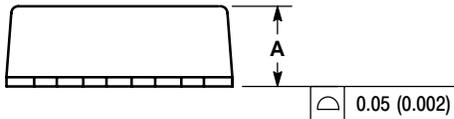


NOTES:

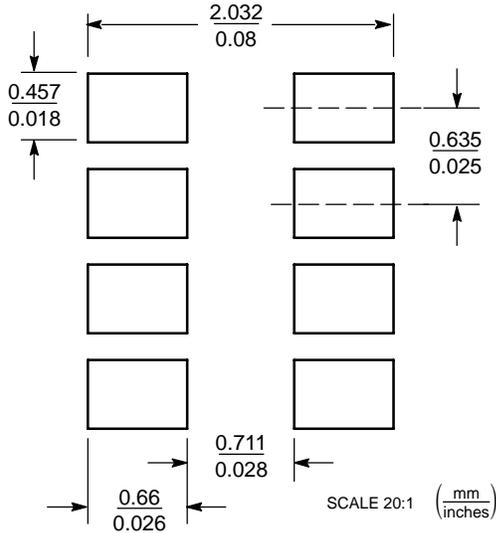
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
4. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
5. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
6. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.

DIM	MILLIMETERS			INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	1.00	1.05	1.10	0.039	0.041	0.043
b	0.25	0.30	0.35	0.010	0.012	0.014
c	0.10	0.15	0.20	0.004	0.006	0.008
D	2.95	3.05	3.10	0.116	0.120	0.122
E	1.55	1.65	1.70	0.061	0.065	0.067
e	0.65 BSC			0.025 BSC		
e1	0.55 BSC			0.022 BSC		
L	0.28	0.35	0.42	0.011	0.014	0.017
H _E	1.80	1.90	2.00	0.071	0.075	0.079
θ	5° NOM			5° NOM		

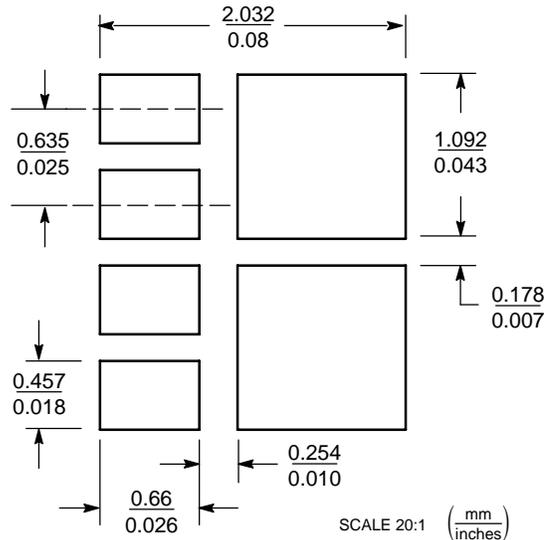
- STYLE 2:
PIN 1. SOURCE 1
2. GATE 1
3. SOURCE 2
4. GATE 2
5. DRAIN 2
6. DRAIN 1
7. DRAIN 1
8. DRAIN 1



SOLDERING FOOTPRINT*



Basic



Style 2

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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